

The CD54HC158 and CD74HC158 are obsolete and no longer are supplied.

Data sheet acquired from Harris Semiconductor SCHS153C

CD54/74HC157, CD54/74HCT157, CD54/74HC158, CD54/74HCT158

September 1997 - Revised October 2003

Features

- Common Select Inputs
- Separate Enable Inputs
- Buffered inputs and Outputs
- Fanout (Over Temperature Range)
 - Standard Outputs 10 LSTTL Loads
 - Bus Driver Outputs 15 LSTTL Loads
- Wide Operating Temperature Range ... -55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
 - 2V to 6V Operation
 - High Noise Immunity: N_{IL} = 30%, N_{IH} = 30% of V_{CC} at V_{CC} = 5V
- HCT Types
 - 4.5V to 5.5V Operation
 - Direct LSTTL Input Logic Compatibility, V_{IL}= 0.8V (Max), V_{IH} = 2V (Min)
 - CMOS Input Compatibility, IJ \leq 1µA at VOL, VOH

Pinout

CD54HC157, CD54HCT157, CD54HC158, CD54HCT158 (CERDIP) CD74HC157, CD74HCT157, CD74HC158 (PDIP, SOIC) CD74HCT158 (PDIP) TOP VIEW S 1 16 V_{CC} 1l₀ 2 15 E 14 4I₀ 1l₁ 3 1Y 4 13 4l₁ 12 4Y 2l₀ 5 2l₁ 6 11 3I₀ 10 3I₁ 2Y 7 9 3Y GND 8

High-Speed CMOS Logic Quad 2-Input Multiplexers

Description

The 'HC157, 'HCT157, 'HC158, and 'HCT158 are quad 2-input multiplexers which select four bits of data from two sources under the control of a common Select input (S). The Enable input (\overline{E}) is active Low. When (\overline{E}) is High, all of the outputs in the 158, the inverting type, ($\overline{1Y}$ - $\overline{4Y}$) are forced High and in the 157, the non-inverting type, all of the outputs ($\overline{1Y}$ - $\overline{4Y}$) are forced Low, regardless of all other input conditions.

Moving data from two groups of registers to four common output buses is a common use of these devices. The state of the Select input determines the particular register from which the data comes. They can also be used as function generators.

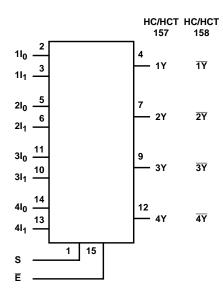
Ordering Information

PART NUMBER	TEMP. RANGE (^o C)	PACKAGE
CD54HC157F3A	-55 to 125	16 Ld CERDIP
CD54HCT157F3A	-55 to 125	16 Ld CERDIP
CD54HCT158F3A	-55 to 125	16 Ld CERDIP
CD74HC157E	-55 to 125	16 Ld PDIP
CD74HC157M	-55 to 125	16 Ld SOIC
CD74HC157MT	-55 to 125	16 Ld SOIC
CD74HC157M96	-55 to 125	16 Ld SOIC
CD74HCT157E	-55 to 125	16 Ld PDIP
CD74HCT157M	-55 to 125	16 Ld SOIC
CD74HCT157MT	-55 to 125	16 Ld SOIC
CD74HCT157M96	-55 to 125	16 Ld SOIC
CD74HCT158E	-55 to 125	16 Ld PDIP

NOTE: When ordering, use the entire part number. The suffix 96 denotes tape and reel. The suffix T denotes a small-quantity reel of 250.

CAUTION: These devices are sensitive to electrostatic discharge. Users should follow proper IC Handling Procedures. Copyright © 2003, Texas Instruments Incorporated

Functional Diagram



TRUTH TABLE

	SELECT			OUTPUT			
ENABLE	INPUT	DATA I	NPUTS	157	158		
Ē	S	10	11	Y	Ÿ		
н	Х	Х	Х	L	Н		
L	L	L	х	L	Н		
L	L	Н	х	Н	L		
L	Н	Х	L	L	Н		
L	Н	Х	Н	Н	L		

H = High Voltage Level, L = Low Voltage Level, X = Don't Care

Absolute Maximum Ratings

DC Supply Voltage, V _{CC}
DC Input Diode Current, I _{IK}
For $V_I < -0.5V$ or $V_I > V_{CC} + 0.5V$
DC Output Diode Current, I _{OK}
For $V_0 < -0.5V$ or $V_0 > V_{CC} + 0.5V$
DC Output Source or Sink Current per Output Pin, IO
For $V_0 > -0.5V$ or $V_0 < V_{CC} + 0.5V$
DC V _{CC} or Ground Current, I _{CC or} I _{GND} ±50mA
Operating Conditions

Temperature Range (T _A)55 ^o C to 125 ^o C
Supply Voltage Range, V _{CC}
HC Types
HCT Types4.5V to 5.5V
DC Input or Output Voltage, V _I , V _O 0V to V _{CC}
Input Rise and Fall Time
2V
4.5V 500ns (Max)
6V

Thermal Information

Thermal Resistance (Typical, Note 1)	θ _{JA} (^o C/W)
E (PDIP) Package	67
M (SOIC) Package	73
Maximum Junction Temperature	
Maximum Storage Temperature Range6	65°C to 150°C
Maximum Lead Temperature (Soldering 10s)	
(SOIC - Lead Tips Only)	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. The package thermal impedance is calculated in accordance with JESD 51-7.

DC Electrical Specifications

		TE: CONDI		v _{cc}		25 ⁰ C		-40 ⁰ C 1	O 85°C	-55 ⁰ C TO 125 ⁰ C		
PARAMETER	SYMBOL	V _I (V)	I _O (mA)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES					-		_	-				-
High Level Input	VIH	-	-	2	1.5	-	-	1.5	-	1.5	-	V
Voltage				4.5	3.15	-	-	3.15	-	3.15	-	V
				6	4.2	-	-	4.2	-	4.2	-	V
Low Level Input Voltage	VIL	-	-	2	-	-	0.5	-	0.5	-	0.5	V
				4.5	-	-	1.35	-	1.35	-	1.35	V
				6	-	-	1.8	-	1.8	-	1.8	V
High Level Output Voltage CMOS Loads	VOH	V _{IH} or V _{IL}	-0.02	2	1.9	-	-	1.9	-	1.9	-	V
			-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
			-0.02	6	5.9	-	-	5.9	-	5.9	-	V
High Level Output			-	-	-	-	-	-	-	-	-	V
Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V
			-5.2	6	5.48	-	-	5.34	-	5.2	-	V
Low Level Output	VOL	V _{IH} or V _{IL}	0.02	2	-	-	0.1	-	0.1	-	0.1	V
Voltage CMOS Loads			0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
			0.02	6	-	-	0.1	-	0.1	-	0.1	V
Low Level Output			-	-	-	-	-	-	-	-	-	V
Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V
TTE LOAUS			5.2	6	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	lı	V _{CC} or GND	-	6	-	-	±0.1	-	±1	-	±1	μA
Quiescent Device Current	Icc	V _{CC} or GND	0	6	-	-	8	-	80	-	160	μA

CD54/74HC157, CD54/74HCT157, CD54/74HC158, CD54/74HCT158

DC Electrical Specifications (Continued)

PARAMETER		TES CONDI		V _{CC}		25 ⁰ C		-40°C T	O 85°C	-55°C TO 125°C		
	SYMBOL	V _I (V)	I _O (mA)	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HCT TYPES	-										-	
High Level Input Voltage	VIH	-	-	4.5 to 5.5	2	-	-	2	-	2	-	V
Low Level Input Voltage	V _{IL}	-	-	4.5 to 5.5	-	-	0.8	-	0.8	-	0.8	V
High Level Output Voltage CMOS Loads	V _{OH}	V _{IH} or V _{IL}	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
High Level Output Voltage TTL Loads			-4	4.5	3.98	-	-	3.84	-	3.7	-	V
Low Level Output Voltage CMOS Loads	V _{OL}	V _{IH} or V _{IL}	0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
Low Level Output Voltage TTL Loads			4	4.5	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	lı	V _{CC} and GND	0	5.5	-		±0.1	-	±1	-	±1	μA
Quiescent Device Current	Icc	V _{CC} or GND	0	5.5	-	-	8	-	80	-	160	μA
Additional Quiescent Device Current Per Input Pin: 1 Unit Load	∆I _{CC} (Note 2)	V _{CC} -2.1	-	4.5 to 5.5	-	100	360	-	450	-	490	μA

NOTE:

2. For dual-supply systems theoretical worst case (V_I = 2.4V, V_{CC} = 5.5V) specification is 1.8mA.

HCT Input Loading Table

	UNIT L	OADS
INPUT	HCT157	HCT158
I (All)	0.95	0.4
Ē	0.6	0.6
S	3	2.8

NOTE: Unit Load is ΔI_{CC} limit specified in DC Electrical Table, e.g., $360\mu A$ max at $25^{\circ}C$.

Switching Specifications Input t_r, t_f = 6ns

		TEST	Vcc	25 ⁰ C			-40°C TO 85°C		-55°C TO 125°C		
PARAMETER	SYMBOL	CONDITIONS	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC/HCT157 TYPES											
Propagation Delay (Figure 1)	t _{PLH} , t _{PHL}	$C_L = 50 pF$	2	-	-	125	-	155	-	190	ns
Data to Output			4.5	-	-	25	-	31	-	38	ns
HC157		C _L =15pF	5	-	10	-	-	-	-	-	ns
HCT157				-	12	-	-	-	-	-	ns
		$C_L = 50 pF$	6	-	-	21	-	26	-	32	ns

CD54/74HC157, CD54/74HCT157, CD54/74HC158, CD54/74HCT158

		TEST	Vcc		25°C		-40 ⁰ C 1	O 85°C	-55°C T	O 125 ⁰ C	
PARAMETER	SYMBOL	CONDITIONS	(V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
Enable to Output	t _{PLH} , t _{PHL}	C _L = 50pF	2	-	-	135	-	170	-	205	ns
			4.5	-	-	27	-	34	-	41	ns
HC157		C _L =15pF	5	-	11	-	-	-	-	-	ns
HCT157				-	12	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	23	-	29	-	35	ns
Select to Output	t _{PLH} , t _{PHL}	$C_L = 50 pF$	2	-	-	145	-	180	-	220	ns
			4.5	-	-	29	-	36	-	44	ns
HC157		C _L =15pF	5	-	12	-	-	-	-	-	ns
HCT157				-	15	-	-	-	-	-	ns
		$C_L = 50 pF$	6	-	-	25	-	31	-	38	ns
Power Dissipation Capacitance (Notes 3, 4)	C _{PD}	-	5								
HC157				-	62	-	-	-	-	-	pF
HCT157				-	70	-	-	-	-	-	pF
HC/HCT158 TYPES											
Data to Output	t _{PLH} , t _{PHL}	$C_L = 50 pF$	2	-	-	140	-	175	-	210	ns
HC158			4.5	-	-	28	-	35	-	42	
		C _L =15pF	5	-	11	-	-	-	-	-	ns
HCT 158				-	13	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	24	-	30	-	36	ns
Enable to Output	t _{PLH} , t _{PHL}	C _L = 50pF	2	-	-	160	-	200	-	240	ns
			4.5	-	-	32	-	40	-	48	ns
HC158		C _L =15pF	5	-	13	-	-	-	-	-	ns
HCT 158				-	15	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	27	-	34	-	41	ns
Select to Output	^t PLH, ^t PHL	$C_L = 50 pF$	2	-	-	150	-	190	-	225	ns
			4.5	-	-	30	-	38	-	45	ns
HC158		C _L =15pF	5	-	12	-	-	-	-	-	ns
HCT 158				-	14	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	26	-	33	-	38	ns
Output Transition Time	t _{TLH} , t _{THL}	C _L = 50pF	2	-	-	75	-	95	-	110	ns
			4.5	-	-	15	-	19	-	22	ns
			6	-	-	13	-	16	-	19	ns
Power Dissipation Capacitance (Notes 3, 4)	C _{PD}	- 7	5								
HC158				-	35	-	-	-	-	-	pF
HCT 158				-	35	-	-	-	-	-	pF
Input Capacitance	C _{IN}	C _L = 50pF	-	-	-	10	-	10	-	10	pF

NOTES:

3. $C_{\mbox{PD}}$ is used to determine the dynamic power consumption, per multiplexer.

4. $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$ where f_i = input frequency, C_L = output load capacitance, V_{CC} = supply voltage.

Test Circuits and Waveforms 🗕 t_f = 6ns t_r = 6ns t_f = 6ns t_r = 6ns -- 3V - V_{CC} 90% 2.7V INPUT INPUT 50% 1.3V 1**0**% 0.3V GND GND - t_{TLH} t_{THL} - t_{TLH} t_{THL} 90% · 90% 50% _1.3V 10% INVERTING INVERTING 1**0%** OUTPUT OUTPUT t_{PHL} tргн tPHL t_{PLH} FIGURE 2. HCT TRANSITION TIMES AND PROPAGATION FIGURE 1. HC AND HCU TRANSITION TIMES AND PROPAGA-TION DELAY TIMES, COMBINATION LOGIC DELAY TIMES, COMBINATION LOGIC



10-Jun-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type		Pins	-	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
5962-9070201MEA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9070201ME A	Samples
										CD54HCT157F3A	
5962-9070301MEA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9070301ME A	Samples
										CD54HCT158F3A	
CD54HC157F	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54HC157F	Samples
CD54HC157F3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-8606101EA CD54HC157F3A	Samples
CD54HCT157F3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9070201ME A	Samples
										CD54HCT157F3A	
CD54HCT158F3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	5962-9070301ME	C1
								0 71		A	Samples
										CD54HCT158F3A	
CD74HC157E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC157E	Samples
CD74HC157EE4	ACTIVE	PDIP	Ν	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC157E	Samples
CD74HC157M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC157M	Samples
CD74HC157M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC157M	Samples
CD74HC157M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC157M	Samples
CD74HC157M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC157M	Samples
CD74HC157MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC157M	Samples
CD74HC157MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC157M	Samples
CD74HCT157E	ACTIVE	PDIP	Ν	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT157E	Samples



10-Jun-2014

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CD74HCT157M	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT157M	Samples
CD74HCT157M96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT157M	Samples
CD74HCT157M96E4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT157M	Samples
CD74HCT157M96G4	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT157M	Samples
CD74HCT157MG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT157M	Samples
CD74HCT157MT	ACTIVE	SOIC	D	16	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT157M	Samples
CD74HCT158E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT158E	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



PACKAGE OPTION ADDENDUM

10-Jun-2014

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD54HC157, CD54HC157, CD54HC158, CD74HC157, CD74HC157, CD74HC158 :

- Catalog: CD74HC157, CD74HCT157, CD74HCT158
- Military: CD54HC157, CD54HCT157, CD54HCT158

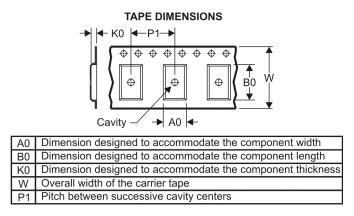
NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nomina	al											
Device		Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC157M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD74HCT157M96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1



PACKAGE MATERIALS INFORMATION

19-Mar-2008



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC157M96	SOIC	D	16	2500	333.2	345.9	28.6
CD74HCT157M96	SOIC	D	16	2500	333.2	345.9	28.6

J (R-GDIP-T**) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



4211283-4/E 08/12

D (R-PDSO-G16) PLASTIC SMALL OUTLINE Stencil Openings (Note D) Example Board Layout (Note C) –16x0,55 -14x1,27 -14x1,27 16x1,50 5,40 5.40 Example Non Soldermask Defined Pad Example Pad Geometry (See Note C) 0,60 .55 Example 1. Solder Mask Opening (See Note E) -0,07 All Around

NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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